

Silicon Carbide (SiC) MOSFET - EliteSiC, 32 mohm, 650 V, M3S, TO-247-4L

NVH4L032N065M3S

Features

- Typical $R_{DS(on)} = 32 \text{ m}\Omega$ @ $V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge $(Q_{G(tot)} = 55 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 114 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb–Free 2LI (on second level interconnection)

Applications

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

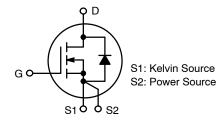
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V_{DSS}	650	V	
Gate-to-Source Voltage		V_{GS}	-8/+22	V
Continuous Drain Current	T _C = 25°C	I _D	50	Α
Power Dissipation	T _C = 25°C	P_{D}	187	W
Continuous Drain Current (Note 1)	T _C = 100°C	Ι _D	30	Α
Power Dissipation	T _C = 100°C	P_{D}	94	W
Pulsed Drain Current (Note 2)	T _C = 25°C t _p = 100 μs	I _{DM}	163	Α
Continuous Source-Drain Current (Body Diode)	$T_C = 25^{\circ}C$ $V_{GS} = -3 V$	I _S	29	Α
Continuous Source-Drain Current (Body Diode)	$T_C = 100^{\circ}C$ $V_{GS} = -3 V$	I _S	16	Α
Pulsed Source-Drain Current (Body Diode) (Note 2)	$T_{C} = 100^{\circ}C$ $V_{GS} = -3 V$ $t_{p} = 100 \mu s$	I _{SM}	137	A
Single Pulse Avalanche Energy (Note 3)	I _{LPK} = 16.7 A, L = 1 mH	E _{AS}	139	mJ
Operating Junction and Storage T Range	T _J , T _{stg}	-55 to +175	°C	
Lead Temperature for Soldering P (1/8" from case for 10 seconds)	TL	270	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 30 A is limited by package. Power chip max drain current is 35 A if limited by max junction temperature.
- 2. Single pulse, limited by max junction temperature.
- 3. EAS of 139 mJ is based on starting $T_J = 25^{\circ}C$, L = 1 mH, $I_{AS} = 16.7$ A, $V_{DD} = 100$ V, $V_{GS} = 18$ V.

V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX
650 V	32 m Ω @ V _{GS} = 18 V	50 A



N-CHANNEL MOSFET



MARKING DIAGRAM



H4L032065M3S = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping
NVH4L032N065M3S	TO-247-4L	30 Units / Tube

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Note 4)	$R_{ heta JC}$	0.8	°C/W
Thermal Resistance, Junction-to-Ambient (Note 4)	$R_{ heta JA}$	40	

^{4.} The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	650	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/ \Delta T_J$	I _D = 1 mA, Referenced to 25°C	_	90	-	mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 650 V, T _J = 25°C	_	-	10	μΑ
		V _{DS} = 650 V, T _J = 175°C (Note 6)	-	-	500	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = -8/+22 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±1.0	μΑ
ON CHARACTERISTICS	<u>-</u>		-	-	-	•
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 18 V, I _D = 15 A, T _J = 25°C	-	32	44	mΩ
		V _{GS} = 18 V, I _D = 15 A, T _J = 175°C (Note 6)	-	49	_	
		V _{GS} = 15 V, I _D = 15 A, T _J = 25°C	-	41	-	1
		V _{GS} = 15 V, I _D = 15 A, T _J = 175°C (Note 6)	_	52	-	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 7.5 \text{ mA}, T_J = 25^{\circ}\text{C}$	2	2.9	4	V
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 15 A (Note 6)	_	9.9	_	S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C _{ISS}	V _{DS} = 400 V, V _{GS} = 0 V, f = 1 MHz	_	1410	-	pF
Output Capacitance	C _{OSS}	(Note 6)	_	114	-	1
Reverse Transfer Capacitance	C _{RSS}		_	9.2	-	1
Total Gate Charge	Q _{G(TOT)}	V _{DD} = 400 V, I _D = 15 A,	-	55	-	nC
Gate-to-Source Charge	Q_{GS}	$V_{GS} = -3/18 \text{ V (Note 6)}$	-	15	-	
Gate-to-Drain Charge	Q _{GD}		_	14	-	1
Gate Resistance	R_{G}	f = 1 MHz	-	5.0	_	Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$	_	8.8	-	ns
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 15 \text{ A}, R_G = 4.7 \Omega, T_J = 25^{\circ}\text{C}$ (Notes 5 and 6)	_	31	-	1
Rise Time	t _r	, ,	-	12	-	1
Fall Time	t _f		-	9	-	
Turn-On Switching Loss	E _{ON}		-	33	-	μJ
Turn-Off Switching Loss	E _{OFF}		_	16	_	
Total Switching Loss	E _{TOT}		-	49	_	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	•		-	•	-	-
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -3/18 \text{ V}, V_{DD} = 400 \text{ V},$	_	7.8	_	ns
Turn-Off Delay Time	t _{d(OFF)}	I_D = 15 A, R_G = 4.7 Ω, T_J = 175°C (Notes 5 and 6)	_	37	_	
Rise Time	t _r	, , , , , , , , , , , , , , , , , , , ,	_	12	_	
Fall Time	t _f	1	_	11	_	
Turn-On Switching Loss	E _{ON}	7	_	31	_	μJ
Turn-Off Switching Loss	E _{OFF}	1	_	25	_	
Total Switching Loss	E _{TOT}		_	56	_	
SOURCE-TO-DRAIN DIODE CHARA	CTERISTICS					
Forward Diode Voltage	V _{SD}	$I_{SD} = 15 \text{ A}, V_{GS} = -3 \text{ V}, T_{J} = 25^{\circ}\text{C}$	_	4.5	6.0	V
		I _{SD} = 15 A, V _{GS} = -3 V, T _J = 175°C (Note 6)	-	4.1	-	
Reverse Recovery Time	t _{RR}	$V_{GS} = -3 \text{ V}, I_{S} = 15 \text{ A},$	_	15.5	_	ns
Charge Time	ta	dl/dt = 1000 A/μs, V _{DS} = 400 V, T _{.1} = 25°C (Note 6)	_	8.9	-	
Discharge Time	t _b]	_	6.6	-	
Reverse Recovery Charge	Q _{RR}	1	-	72	_	nC
Reverse Recovery Energy	E _{REC}	1	-	4.6	_	μJ
Peak Reverse Recovery Current	I _{RRM}	1	-	9.3	_	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. EON/EOFF result is with body diode.

^{6.} Defined by design, not subject to production test.

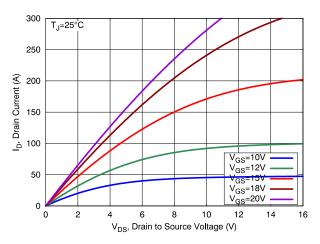


Figure 1. Output Characteristics

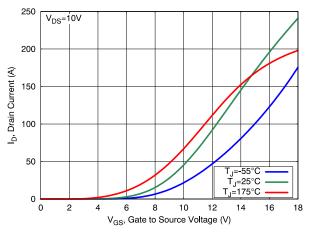


Figure 3. Transfer Characteristics

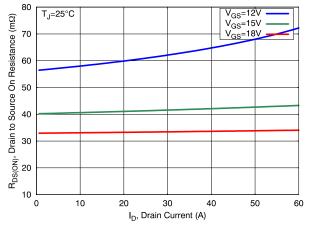


Figure 5. On-Resistance vs. Drain Current

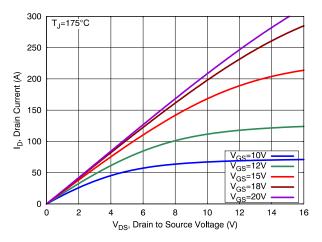


Figure 2. Output Characteristics

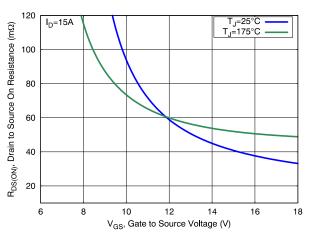


Figure 4. On-Resistance vs. Gate Voltage

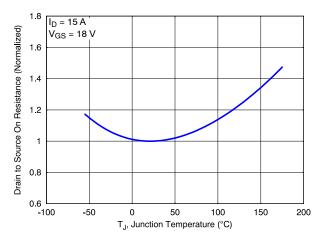


Figure 6. On-Resistance vs. Junction Temperature

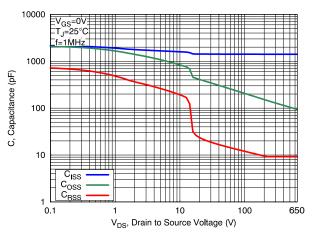


Figure 7. Capacitance Characteristics

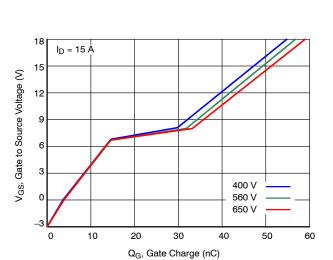


Figure 9. Gate Charge Characteristics

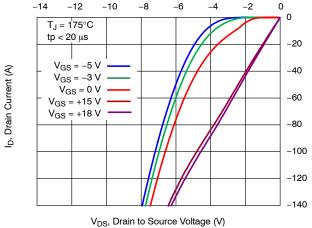


Figure 11. Reverse Conduction Characteristics

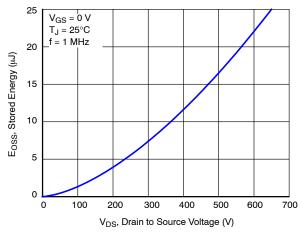


Figure 8. Stored Energy vs. Drain-to-Source Voltage

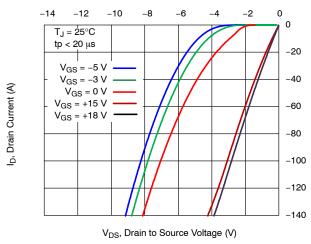


Figure 10. Reverse Conduction Characteristics

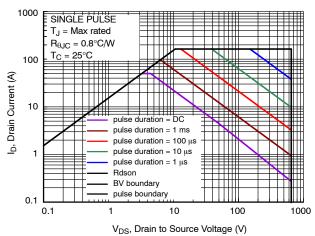


Figure 12. Safe Operating Area

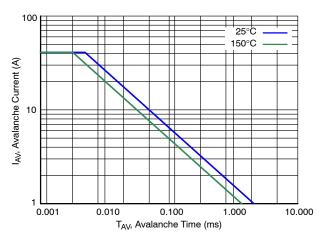


Figure 13. Avalanche Current vs. Pulse Time (UIS)

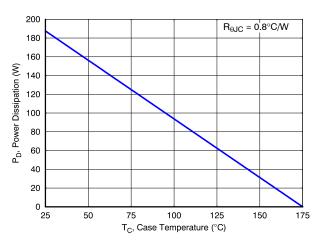


Figure 14. Maximum Power Dissipation vs.

Case Temperature

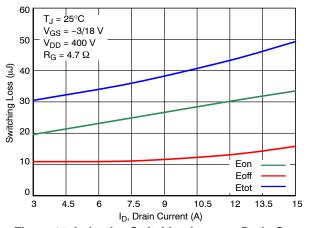


Figure 15. Inductive Switching Loss vs. Drain Current

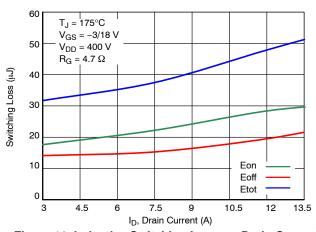


Figure 16. Inductive Switching Loss vs. Drain Current

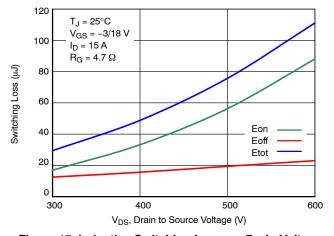


Figure 17. Inductive Switching Loss vs. Drain Voltage

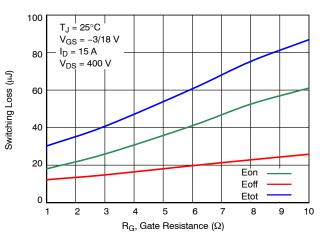


Figure 18. Inductive Switching Loss vs.
Gate Resistance

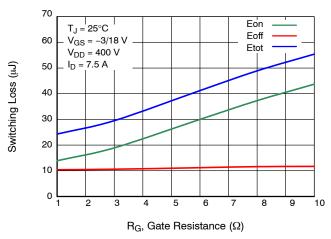


Figure 19. Inductive Switching Loss vs. Gate Resistance

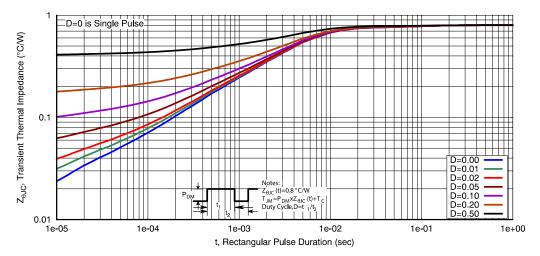


Figure 20. Thermal Response Characteristics

 \emptyset p1

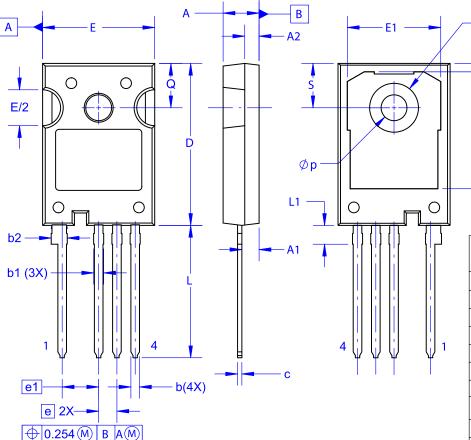
D1

D2



TO-247-4LD CASE 340CJ **ISSUE A**

DATE 16 SEP 2019



NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
 B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD
 FLASH, AND TIE BAR EXTRUSIONS.
 C. ALL DIMENSIONS ARE IN MILLIMETERS.
 D. DRAWING CONFORMS TO ASME Y14.5-2009.

DIM	MILLIMETERS				
DIM	MIN NOM		MAX		
Α	4.80	5.00	5.20		
A1	2.10	2.40	2.70		
A2	1.80	2.00	2.20		
b	1.07	1.20	1.33		
b1	1.20	1.40	1.60		
b2	2.02	2.22	2.42		
С	0.50	0.60	0.70		
D	22.34	22.54	22.74		
D1	16.00	16.25	16.50		
D2	0.97	1.17	1.37		
е	2.54 BSC				
e1		5.08 BSC			
E	15.40	15.60	15.80		
E1	12.80	13.00	13.20		
E/2	4.80	5.00	5.20		
L	18.22	18.42	18.62		
L1	2.42	2.62	2.82		
р	3.40	3.60	3.80		
p1	6.60	6.80	7.00		
Q	5.97	6.17	6.37		
S	5.97	6.17	6.37		

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